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HOGAN & HARTSON L.L.P.			LOKE, STEVEN HO YIN	
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Please find below and/or attached an Office communication concerning this application or proceeding.

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	Application No.	Applicant(s)				
Office Action Commence	10/731,336	SUGAWARA, HIDETO				
Office Action Summary	Examiner	Art Unit				
	Steven Loke	2811				
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet with the c	orrespondence address				
A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING DA - Extensions of time may be available under the provisions of 37 CFR 1.13 after SIX (6) MONTHS from the mailing date of this communication If NO period for reply is specified above, the maximum statutory period w - Failure to reply within the set or extended period for reply will, by statute, Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUNICATION 36(a). In no event, however, may a reply be tim vill apply and will expire SIX (6) MONTHS from cause the application to become ABANDONE	N. nety filed the mailing date of this communication. D (35 U.S.C. § 133).				
Status						
1) Responsive to communication(s) filed on 24 Oc	<u>ctober 2005</u> .					
2a)⊠ This action is FINAL . 2b)☐ This	This action is FINAL . 2b) This action is non-final.					
3) Since this application is in condition for allowar	☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is					
closed in accordance with the practice under E	x parte Quayle, 1935 C.D. 11, 45	53 O.G. 213.				
Disposition of Claims						
4) ⊠ Claim(s) 9,10 and 12-32 is/are pending in the a 4a) Of the above claim(s) is/are withdray 5) □ Claim(s) is/are allowed. 6) ⊠ Claim(s) 9,10 and 12-32 is/are rejected. 7) □ Claim(s) is/are objected to. 8) □ Claim(s) are subject to restriction and/or	vn from consideration.					
Application Papers						
9) The specification is objected to by the Examine 10) The drawing(s) filed on is/are: a) acce Applicant may not request that any objection to the Replacement drawing sheet(s) including the correct 11) The oath or declaration is objected to by the Ex	epted or b) objected to by the Identified or b) objected to by the Identified or by the Ident	e 37 CFR 1.85(a). jected to. See 37 CFR 1.121(d).				
Priority under 35 U.S.C. § 119						
12) Acknowledgment is made of a claim for foreign a) All b) Some * c) None of: 1. Certified copies of the priority documents 2. Certified copies of the priority documents 3. Copies of the certified copies of the prior application from the International Bureau * See the attached detailed Office action for a list	s have been received. s have been received in Applicati rity documents have been receive u (PCT Rule 17.2(a)).	on No ed in this National Stage				
Attachment(s)	_					
Notice of References Cited (PTO-892) Notice of Draftsperson's Patent Drawing Review (PTO-948)	4) Interview Summary Paper No(s)/Mail Da					
3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date		Patent Application (PTO-152)				

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1. Claims 15, 16, 17, 21-23 are rejected under 35 U.S.C. 112, first paragraph, as failing to comply with the written description requirement. The claim(s) contains subject matter which was not described in the specification in such a way as to reasonably convey to one skilled in the relevant art that the inventor(s), at the time the application was filed, had possession of the claimed invention.

Claim 9, the parent claims of claims 16 and 22, discloses a first embodiment (figs. 1-7) of the invention showing protrusions having fine recesses formed on a surface of the protrusions. However, the specification never discloses said large protrusions are higher in height than the small protrusions as claimed in claim 16. The specification also never discloses said large protrusions are higher in height and wider in width than the small protrusions as claimed in claim 22.

Claim 10, the parent claims of claims 17 and 23, discloses a first embodiment (figs. 1-7) of the invention showing protrusions whose surface includes regions out of stoichiometric compositions. However, the specification never discloses said large protrusions are higher in height than the small protrusions as claimed in claim 17. The specification also never discloses said large protrusions are higher in height and wider in width than the small protrusions as claimed in claim 23.

Claim 12, the parent claims of claims 15 and 21, discloses a first embodiment (figs. 1-7) of the invention showing protrusions having fine recesses formed on a surface of the protrusions. However, the specification never discloses said large protrusions are higher in height than the small protrusions as claimed in claim 15. The specification

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also never discloses said large protrusions are higher in height and wider in width than the small protrusions as claimed in claim 21.

2. Claims 9, 10 and 12-32 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

Claim 9, lines 11-12, claim 12, line 13, the phrase "a surface of the protrusions" is vague and indefinite as to how a plurality of protrusions have a single surface. There should be either surfaces for the protrusions or a surface for a protrusion in the device.

Claim 10, lines 11-12, the phrase "protrusions whose surface...." is vague and indefinite as to how a plurality of protrusions have a single surface. There should be either surfaces for the protrusions or a surface for a protrusion in the device.

3. The following is a quotation of the appropriate paragraphs of 35 U.S.C. 102 that form the basis for the rejections under this section made in this Office action:

A person shall be entitled to a patent unless -

- (b) the invention was patented or described in a printed publication in this or a foreign country or in public use or on sale in this country, more than one year prior to the date of application for patent in the United States.
- 4. Claims 9, 12, 13, 15, 18, 19 and 21 insofar, as in compliance with 35 USC 112, are rejected under 35 U.S.C. 102(b) as being clearly anticipated by Hayashi et al. (in the IDS filed on 12/9/03).

In regards to claim 9, Hayashi et al. show all the elements of the claimed invention in fig. 7(f). It is a nitride based semiconductor light-emitting device [102], comprising: a substrate [12]; a first conductive type (p-type) nitride based semiconductor layer [25] formed on the substrate [12]; an active layer [24] (n-InGaN barrier layer/n-InGaN well

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layer) with a p-n junction (formed between the n-type active layer [24] and the p-type cladding layer [25]) formed on said first conductive type nitride based semiconductor layer [25], said active layer being made of a nitride based semiconductor layer having the p-n junction (formed between the n-type active layer [24] and the p-type cladding layer [25]); a second conductive type (n-type) nitride based semiconductor layer [21] formed on said active layer [24], said second conductive type nitride based semiconductor layer [21] being provided with protrusions having fine recesses (the protrusions formed at the bottom of layer [21] having fine recesses.) (See the attached enlarged fig. 7(f) at the end of the Office Action) (the recesses are formed on the first, third, fifth and sixth protrusions from the right side of the bottom of layer [21]) formed on a surface of the protrusions; a first ohmic electrode [11] formed on the surface of said second conductive type nitride based semiconductor layer [21]; and a second ohmic electrode [10] formed on said first conductive type nitride based semiconductor layer [25].

In regards to claim 13, Hayashi et al. show said protrusions have small and large ones.

In regards to claim 19, Hayashi et al. show said large protrusions (third and sixth protrusions) are wider in width than the small protrusions (first and fifth protrusions).

In regards to claim 12, Hayashi et al. show all the elements of the claimed invention in fig. 7(f). It is a nitride based semiconductor light-emitting device [102], comprising: a substrate [12]; a first conductive type (p-type) nitride based semiconductor layer [25] formed on the substrate [12]; an active layer [24] (n-InGaN barrier layer/n-InGaN well

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layer) with a p-n junction (formed between the n-type active layer [24] and the p-type cladding layer [25]) formed on said first conductive type nitride based semiconductor layer [25], said active layer being made of a nitride based semiconductor layer having the p-n junction (formed between the n-type active layer [24] and the p-type cladding layer [25]); a second conductive type (n-type) nitride based semiconductor layer [21] formed on said active layer [24], said second conductive type nitride based semiconductor layer [21] being provided with at least two sizes of protrusions (the first to eleventh protrusions formed at the bottom of layer [21) (See the attached enlarged fig. 7(f) at the end of the Office Action) formed on a surface of the second conductive type nitride based semiconductor layer, said protrusions being provided with fine recesses formed on a surface of the protrusions; a first ohmic electrode [11] formed on the surface of said second conductive type nitride based semiconductor layer [21]; and a second ohmic electrode [10] formed on said first conductive type nitride based semiconductor layer [25].

In regards to claim 15, Hayashi et al. further disclose said at least two sizes of protrusions have large and small ones and said large protrusions (first and second protrusions) are higher in height than the small protrusions (tenth and eleventh protrusions).

In regards to claim 18, Hayashi et al. further disclose said protrusions have small and large ones and said large protrusions (second and third protrusions) are wider in width than the small protrusions (first and eleventh protrusions).

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In regards to claim 21, Hayashi et al. further disclose said protrusions have small and large ones and said large protrusions (first and second protrusions) are higher in height and wider in width than the small protrusions (fifth and eighth protrusions).

- 5. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 6. Claims 16, 22, 24, 25, 27, 29, 30 and 32 are rejected under 35 U.S.C. 103(a) as being unpatentable over Hayashi et al.

In regards to claim 16, Hayashi et al. differ from the claimed invention by not showing said large protrusions are higher in height than the small protrusions.

It would have been obvious for the large protrusions are higher in height than the small protrusions because it depends on the desired contact resistance between the n-type GaN substrate and the n-type ohmic electrode.

In regards to claim 22, Hayashi et al. differ from the claimed invention by not showing said large protrusions are higher in height and wider in width than the small protrusions.

It would have been obvious for said large protrusions are higher in height and wider in width than the small protrusions because it depends on the desired contact resistance between the n-type GaN substrate and the n-type ohmic electrode.

In regards to claim 24, Hayashi et al. disclose said protrusions have small and large ones.

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Hayashi et al. differ from the claimed invention by not showing said large protrusions are wider in width than the small protrusions but said large protrusions are substantially equal in height to the small protrusions.

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It would have been obvious for said large protrusions are wider in width than the small protrusions but said large protrusions are substantially equal in height to the small protrusions because it depends on the desired contact resistance between the n-type GaN substrate and the n-type ohmic electrode.

In regards to claim 25, Hayashi et al. differ from the claimed invention by not showing said large protrusions are wider in width than the small protrusions but said large protrusions are substantially equal in height to the small protrusions.

It would have been obvious for the said large protrusions are wider in width than the small protrusions but said large protrusions are substantially equal in height to the small protrusions because it depends on the desired contact resistance between the n-type GaN substrate and the n-type ohmic electrode.

In regards to claims 27, Hayashi et al. differ from the claimed invention by not showing said large protrusions are substantially hexagons in a plan view.

It would have been obvious for the large protrusions are substantially hexagons in a plan view because it depends on the desired contact resistance between the n-type GaN substrate and the n-type ohmic electrode.

In regards to claims 29, Hayashi et al. differ from the claimed invention by not showing said protrusions are substantially hexagons in a plan view.

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It would have been obvious for the protrusions are substantially hexagons in a plan view because it depends on the desired contact resistance between the n-type GaN substrate and the n-type ohmic electrode.

In regards to claims 30, 32, Hayashi et al. differ from the claimed invention by not showing the second conductive type nitride based semiconductor layer is made from p-type InGaAIN system materials.

It would have been obvious for the second conductive type nitride based semiconductor layer is made from p-type InGaAIN system materials because it depends on the desired contact resistance and the turn-on voltage of the light-emitting device.

7. Applicant's arguments filed 10/24/05 have been fully considered but they are not persuasive.

It is urged, in page 8 of the remarks, that claims 16, 17, 22 and 23 are supported by fig. 8D because protrusion 18a is higher in height than protrusion 18b and wider in width than protrusion 18b. However, fig. 8D is directed to a second embodiment of the invention and it does not have the fine recesses in the protrusion. Only the first embodiment (figs. 5B and 7) has the fine recesses in the protrusion. Therefore, claims 16, 17, 22 and 23 are still rejected under 35 USC 112, first paragraph.

It is urged, in page 10 of the remarks, that there are large recesses formed between and separation the protrusions, but no recesses formed on the surfaces of the protrusions themselves. However, as seen from the enlarged view of the first to eleventh protrusions in fig. 7(f), there are recesses formed on the side and top surfaces of the protrusions. Claims 9 and 12 are still rejected by Hayashi.

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8. Claim 10 would be allowable if rewritten or amended to overcome the rejection(s) under 35 U.S.C. 112, 2nd paragraph, set forth in this Office action.

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9. Applicant's amendment necessitated the new ground(s) of rejection presented in this Office action. Accordingly, **THIS ACTION IS MADE FINAL**. See MPEP § 706.07(a). Applicant is reminded of the extension of time policy as set forth in 37 CFR 1.136(a).

A shortened statutory period for reply to this final action is set to expire THREE MONTHS from the mailing date of this action. In the event a first reply is filed within TWO MONTHS of the mailing date of this final action and the advisory action is not mailed until after the end of the THREE-MONTH shortened statutory period, then the shortened statutory period will expire on the date the advisory action is mailed, and any extension fee pursuant to 37 CFR 1.136(a) will be calculated from the mailing date of the advisory action. In no event, however, will the statutory period for reply expire later than SIX MONTHS from the date of this final action.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Steven Loke whose telephone number is (571) 272-1657. The examiner can normally be reached on 8:00 am to 5:30 pm.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Eddie Lee can be reached on (571) 272-1732. The fax phone number for the organization where this application or proceeding is assigned is 571-273-8300.

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Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

sl January 21, 2006 Steven Loke Primary Examiner Steven Loke

